Notice of References Cited Application/Control No. 09/746,489 Examiner Nadia Khoshnoodi Applicant(s)/Patent Under Reexamination TEICH ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,832,526	11-1998	Schuyler, David E.	707/205
	В	US-6,487,202	11-2002	Klausmeier et al.	370/395.1
	C	US-5,751,993	05-1998	Ofek et al.	711/136
	D	US-6,023,710	02-2000	Steiner et al.	707/204
	Ε	US-6,003,134	12-1999	Kuo et al.	713/200
	F	US-5,974,503	10-1999	Venkatesh et al.	711/114
	G	US-6,230,200	05-2001	Forecast et al.	709/226
	ŀН	US-5,592,432	01-1997	Vishlitzky et al.	365/230.03
	ı	US-6,122,645	09-2000	Bohannon et al.	707/203
	J	US-			·
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Ø					
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	S					
	Т	17 100				

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	8						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.